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Piezoelectric Devices for Frequency Control and Sefection Sectional Committee, LTDC 12 [Ref: Doc: LTDC 12(560)]

Indian Standard

SPECIFICATION FOR QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION

PART II SERIES AA FOR OSCILLATORS

Section 7 Quartz Crystal Unit Type BC-07

- 0. General This standard shall be read in conjunction with IS: 8271 (Part I)-1981 'Specification for quartz crystal units used for frequency control and selection: Part I General requirements and tests (first revision)'.
- 1. Outline and Dimensions Holder outline shall conform to Type AA (see Sheet 1A of IS: 4570-1968 Specification for crystal holders).
- 2. Marking See 8 of IS: 8271 (Part I)-1981.
- 3. Construction and Workmanship See 7 of IS: 8271 (Part I)-1981.
- 4. Test Schedule and Detail Requirements
- 4.1 General Conditions for Test See 9.2 of IS: 8271 (Part I)-1981.
- 4.2 Test Schedule The sequence and grouping of type, routine and acceptance tests shall be as per 9.1 of IS: 8271 (Part i)-1981.
- 4.3 Detail Requirements The detail requirements applicable to this particular type of crystal unit shall be as specified in Table 1.

Adopted 21 April 1982

C September 1982, ISI

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TABLE 1 DETAIL REQUIREMENTS OF QUARTZ CRYSTAL UNIT TYPE AA-07 (Clause 4.3)

SI No.	Characteristic	Requirements	
(1)	(2)	(3)	
i)	Type of holder	AA (see 1)	
ii)	Frequency range	10 to 60 MHz	
iii)	Frequency tolerance: Over operating temperature range	± 50 ppm	
iv)	Resonance resistance	40 Ohms, Max	
v)	Mode of oscillation	Third overtone	
vi)	Load capacitance	Infinity (series)	
vii)	Capacitance shunt	7 pF, <i>Max</i>	
viii)	Operating temperature range	-55°C to + 90°C	
ix)	Test set, calibration values and rated drive level	See Table 2	
x)	Shock [as per 9.15 (Severity A) of IS : 8271 (Part I)-1981]:		
	a) Frequency change permittedb) Resonance resistance change permitted	± 5 ppm ± 10 percent	
xi)	Vibration [as per 9.16.1 (Severity A) of IS: 8271 (Part I)-1981]:		
	a) Frequency change permittedb) Resonance resistance change permitted	± 5 ppm ± 10 percent	
xii)	Temperature cycling:		
	a) Frequency change permittedb) Resonance resistance change permitted	± 5 ppm ± 10 percent	
xiil)	Temperature run:		
	a) Frequency change permitted b) Resonance resistance change permitted	土 5 ppm 土 10 percent	
xiv)	Ageing Frequency change permitted	5.ppm	

TABLE 2 TEST SET, CALIBRATION VALUES AND RATED DRIVE LEVEL

[Table 1, Item (ix)]

Si No.	Frequency	Calibration Values		Rated Drive Level
	Range	Resistance	Resistor Voltage Drop	Level
	MHz	Ohms	Volts	mW
(1)	(2)	(3)	(4)	(5)
i)	From 10 to 15	60	0.49	4·0 ± 0·8
ii)	Over 15 to 25	40	0.40	4.0 ± 0.8
iii)	Over 25 to 60	40	0.58	2.0 ± 0.4
	For SI No. (i) to (iii) —	Test Set TS 683/TSM		